

CSC364/CSCM64 Lab 4

To be solved in groups of two or three.
Last day for lab sign-off: 28th March 2022

Task 1. Consider the boolean formula

$$(\text{not } A \text{ and } B) \text{ and } (C \text{ or } D). \quad (1)$$

Assume that each logical connective in the formula 1 is implemented using a suitable logic gate. The following test suite is designed to test the implementation:

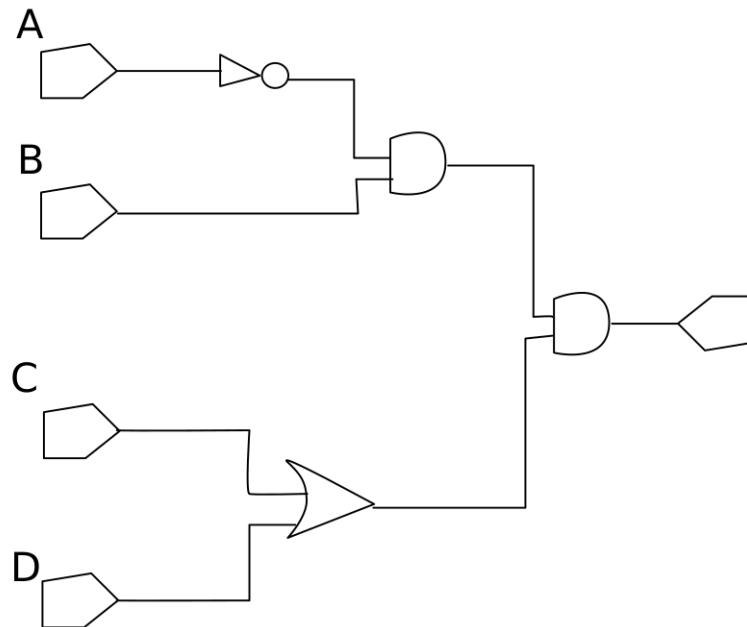
Case	A	B	C	D	Expected Output
1	<i>T</i>	<i>T</i>	<i>T</i>	<i>F</i>	<i>F</i>
2	<i>F</i>	<i>T</i>	<i>F</i>	<i>F</i>	<i>F</i>
3	<i>T</i>	<i>F</i>	<i>T</i>	<i>T</i>	<i>F</i>
4	<i>F</i>	<i>F</i>	<i>F</i>	<i>F</i>	<i>F</i>

It is obvious that this test suite does not satisfy the MC/DC criterion (why?).

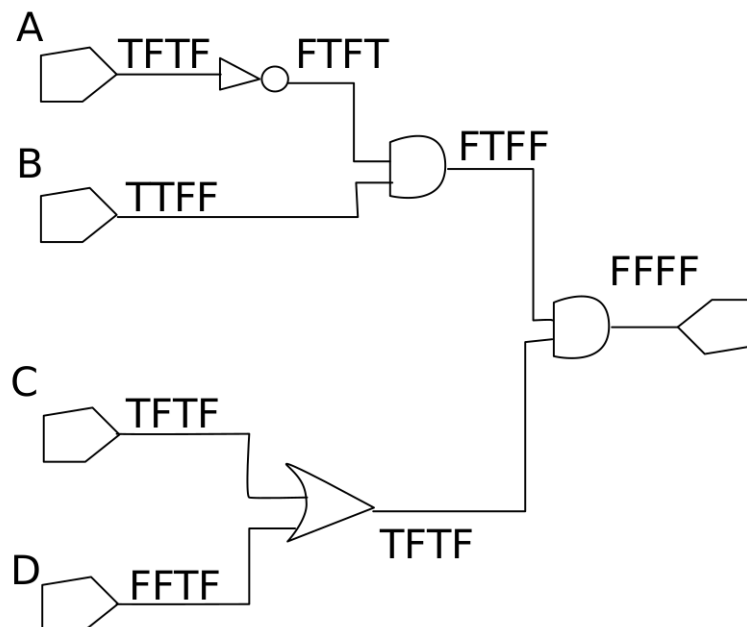
1. Use the first four steps of the five-step evaluation process introduced in the lectures to decide for each individual gate whether the test suite provides MC/DC for that gate (in the sense of the masking approach). Where the test suite does not provide MC/DC for a gate, list all missing test cases. Make all four steps clearly visible.
2. Add further test cases to the above test suite to make it satisfy the MC/DC criterion (in the sense of the masking approach). What is the smallest number of test cases one needs to add?

Answer 1. The test suite obviously does not provide MC/DC because the whole expression has not taken all possible outcomes (true and false).

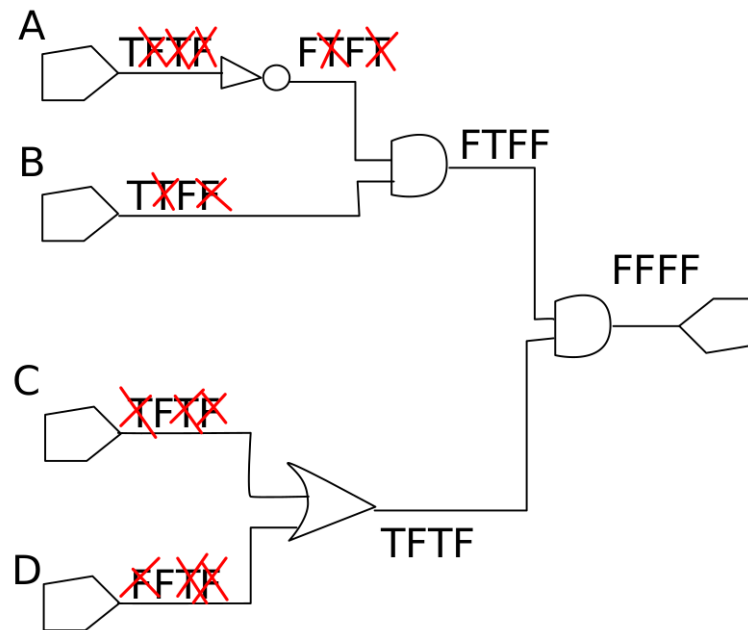
1. **Step 1.** Write down the formula schematically:



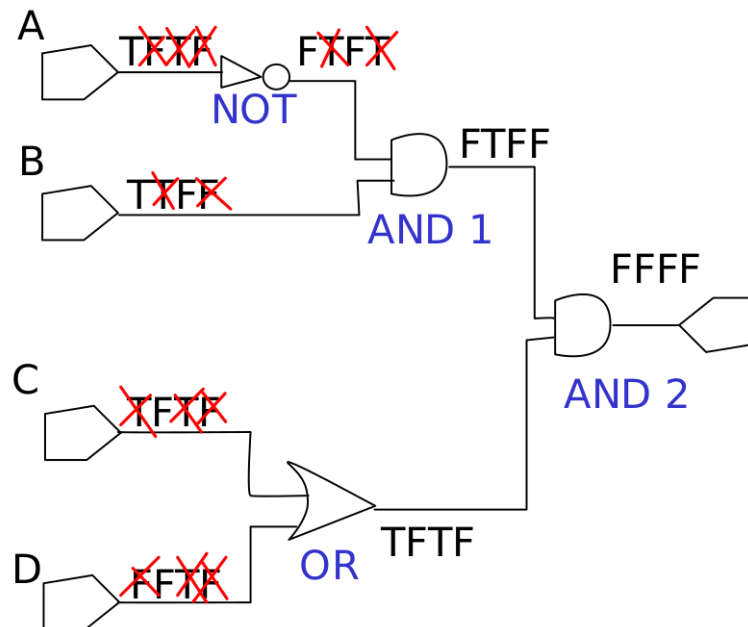
Step 2. Insert test values:



Step 3. Eliminate masked test cases:



Step 4. Verify MC/DC for each gate individually. To this end, let us introduce names for the gates:



The following table lists valid and missing test cases for all gates:

Gate	Valid Test Cases	Missing Test Cases	MC/DC?
NOT	T	F	No.
OR	FF	TF, FT	No.
AND1	FT, FF	TF, TT	No.
AND2	FT, TF, FF	TT	No.

2. The not-gate needs a valid **false** test input. The gate *AND1* needs the inputs TT and TF. We hence need to add at least two test inputs, where *A* is assigned **false** and *B* is assigned **true** and **false** respectively.

The output of the or-gate needs to be **true** for both test inputs to prevent masking. When *B* is assigned **false**, the output of the or-gate will be masked. When *B* is assigned **true**, the output of the or-gate will not be masked. In the latter case we can add a missing test case to the or-gate. This suggests to add the following two inputs:

Case	A	B	C	D	Expected Output
5	<i>F</i>	<i>F</i>	<i>T</i>	<i>T</i>	<i>F</i>
6	<i>F</i>	<i>T</i>	<i>T</i>	<i>F</i>	<i>T</i>

For test case 5 we could have also chosen TF or FT for the assignment to *C* and *D* to prevent masking. For test case 6 we could have also chosen FT for the assignment to *C* and *D* to add this missing test case.

After adding these inputs, the test case FT is still missing for the or-gate. We hence need to add another test input. The variable *C* needs to be assigned the value **false**. The variable *D* needs to be assigned the value **true**. The result of the *AND1*-gate has to be **true** to prevent masking. This only leaves us one choice for the assignment to *A* and *B*:

Case	A	B	C	D	Expected Output
7	<i>F</i>	<i>T</i>	<i>F</i>	<i>T</i>	<i>T</i>

With these three new test cases, we have also added the missing test cases for the gate *AND2*. Hence, the new test suite provides MC/DC. It is clear from our discussion that it was necessary to add three test cases.

A graphical representation of the new test suite is given on the next page.

